



# THE DATASHEET OF AOD423



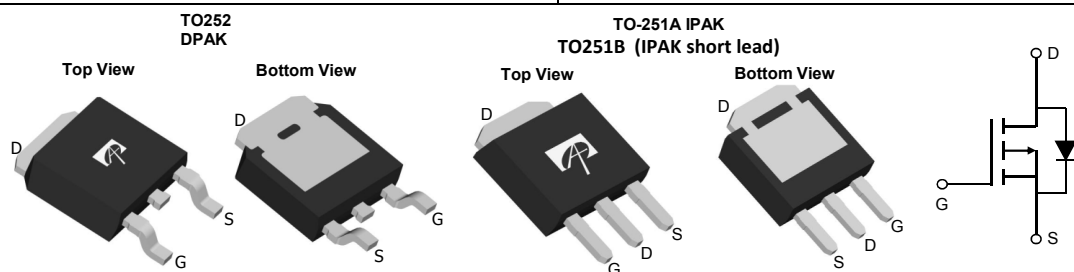
### General Description

The AOD423/AOI423/AOY423 uses advanced trench technology to provide excellent  $R_{DS(ON)}$ , low gate charge and low gate resistance. With the excellent thermal resistance of the DPAK/IPAK package, this device is well suited for high current load applications.

### Product Summary

|                                    |                                      |
|------------------------------------|--------------------------------------|
| $V_{DS}$                           | -30V                                 |
| $I_D$ (at $V_{GS} = -20V$ )        | -70A                                 |
| $R_{DS(ON)}$ (at $V_{GS} = -20V$ ) | < 6.2m $\Omega$ (< 6.7m $\Omega^*$ ) |
| $R_{DS(ON)}$ (at $V_{GS} = -10V$ ) | < 8m $\Omega$ (< 8.5m $\Omega^*$ )   |

100% UIS Tested  
 100%  $R_g$  Tested



| Orderable Part Number | Package Type | Form        | Minimum Order Quantity |
|-----------------------|--------------|-------------|------------------------|
| AOD423                | TO-252       | Tape & Reel | 2500                   |
| AOI423                | TO-251A      | Tube        | 4000                   |
| AOY423                | TO-251B      | Tube        | 4000                   |

### Absolute Maximum Ratings $T_A=25^\circ\text{C}$ unless otherwise noted

| Parameter                                      | Symbol           | Maximum                 | Units            |
|--|------------------|-------------------------|------------------|
| Drain-Source Voltage                           | $V_{DS}$         | -30                     | V                |
| Gate-Source Voltage                            | $V_{GS}$         | $\pm 25$                | V                |
| Continuous Drain Current <sup>G</sup>          | $I_D$            | $T_C=25^\circ\text{C}$  | -70              |
|  |                  | $T_C=100^\circ\text{C}$ | -67              |
| Pulsed Drain Current <sup>C</sup>              | $I_{DM}$         | -200                    | A                |
| Continuous Drain Current                       | $I_{DSM}$        | $T_A=25^\circ\text{C}$  | -15              |
|  |                  | $T_A=70^\circ\text{C}$  | -12              |
| Avalanche Current <sup>C</sup>                 | $I_{AS}, I_{AR}$ | -50                     | A                |
| Avalanche energy $L=0.1\text{mH}$ <sup>C</sup> | $E_{AS}, E_{AR}$ | 125                     | mJ               |
| Power Dissipation <sup>B</sup>                 | $P_D$            | $T_C=25^\circ\text{C}$  | 90               |
|  |                  | $T_C=100^\circ\text{C}$ | 45               |
| Power Dissipation <sup>A</sup>                 | $P_{DSM}$        | $T_A=25^\circ\text{C}$  | 2.5              |
|  |                  | $T_A=70^\circ\text{C}$  | 1.6              |
| Junction and Storage Temperature Range         | $T_J, T_{STG}$   | -55 to 175              | $^\circ\text{C}$ |

### Thermal Characteristics

| Parameter                                  | Symbol          | Typ | Max | Units              |
|--|-----------------|-----|-----|--------------------|
| Maximum Junction-to-Ambient <sup>A</sup>   | $R_{\theta JA}$ | 16  | 20  | $^\circ\text{C/W}$ |
| Maximum Junction-to-Ambient <sup>A,D</sup> |                 | 41  | 50  | $^\circ\text{C/W}$ |
| Maximum Junction-to-Case                   | $R_{\theta JC}$ | 0.9 | 1.6 | $^\circ\text{C/W}$ |

\* package TO251A, TO251B

**Electrical Characteristics (T<sub>J</sub>=25°C unless otherwise noted)**

| Symbol                      | Parameter  | Conditions   | Min  | Typ        | Max        | Units |
|-----------------------------|--|--|------|------------|------------|-------|
| <b>STATIC PARAMETERS</b>    |  |  |      |            |            |       |
| BV <sub>DSS</sub>           | Drain-Source Breakdown Voltage                     | I <sub>D</sub> =-250μA, V <sub>GS</sub> =0V  | -30  |            |            | V     |
| I <sub>DSS</sub>            | Zero Gate Voltage Drain Current                    | V <sub>DS</sub> =-30V, V <sub>GS</sub> =0V<br>T <sub>J</sub> =55°C                           |      |            | -1<br>-5   | μA    |
| I <sub>GSS</sub>            | Gate-Body leakage current                          | V <sub>DS</sub> =0V, V <sub>GS</sub> = ±25V  |      |            | ±100       | nA    |
| V <sub>GS(th)</sub>         | Gate Threshold Voltage                             | V <sub>DS</sub> =V <sub>GS</sub> I <sub>D</sub> =-250μA                                      | -1.5 | -2.5       | -3.5       | V     |
| I <sub>D(ON)</sub>          | On state drain current                             | V <sub>GS</sub> =-10V, V <sub>DS</sub> =-5V  | -200 |            |            | A     |
| R <sub>DS(ON)</sub>         | Static Drain-Source On-Resistance                  | V <sub>GS</sub> =-20V, I <sub>D</sub> =-20A<br>TO252<br>T <sub>J</sub> =125°C                |      | 5.1<br>7.6 | 6.2<br>9.2 | mΩ    |
|                             |  | V <sub>GS</sub> =-10V, I <sub>D</sub> =-20A<br>TO252   |      | 6.2        | 8          | mΩ    |
|                             |  | V <sub>GS</sub> =-20V, I <sub>D</sub> =-20A<br>TO251A, TO251B                                |      | 5.6        | 6.7        | mΩ    |
|                             |  | V <sub>GS</sub> =-10V, I <sub>D</sub> =-20A<br>TO251A, TO251B                                |      | 6.7        | 8.5        | mΩ    |
| g <sub>FS</sub>             | Forward Transconductance                           | V <sub>DS</sub> =-5V, I <sub>D</sub> =-20A   |      | 42         |            | S     |
| V <sub>SD</sub>             | Diode Forward Voltage                              | I <sub>S</sub> =-1A, V <sub>GS</sub> =0V   |      | -0.7       | -1         | V     |
| I <sub>S</sub>              | Maximum Body-Diode Continuous Current <sup>G</sup> |  |      |            | -70        | A     |
| <b>DYNAMIC PARAMETERS</b>   |  |  |      |            |            |       |
| C <sub>iss</sub>            | Input Capacitance                                  | V <sub>GS</sub> =0V, V <sub>DS</sub> =-15V, f=1MHz   |      | 2760       |            | pF    |
| C <sub>oss</sub>            | Output Capacitance                                 |  |      | 550        |            | pF    |
| C <sub>rss</sub>            | Reverse Transfer Capacitance                       |  |      | 375        |            | pF    |
| R <sub>g</sub>              | Gate resistance                                    | V <sub>GS</sub> =0V, V <sub>DS</sub> =0V, f=1MHz   | 1.5  | 3          | 6.0        | Ω     |
| <b>SWITCHING PARAMETERS</b> |  |  |      |            |            |       |
| Q <sub>g</sub>              | Total Gate Charge                                  | V <sub>GS</sub> =-10V, V <sub>DS</sub> =-15V, I <sub>D</sub> =-20A                           |      | 45         | 65         | nC    |
| Q <sub>gs</sub>             | Gate Source Charge                                 |  |      | 10         |            | nC    |
| Q <sub>gd</sub>             | Gate Drain Charge                                  |  |      | 12         |            | nC    |
| t <sub>D(on)</sub>          | Turn-On DelayTime                                  | V <sub>GS</sub> =-10V, V <sub>DS</sub> =-15V, R <sub>L</sub> =0.75Ω,<br>R <sub>GEN</sub> =3Ω |      | 13         |            | ns    |
| t <sub>r</sub>              | Turn-On Rise Time                                  |  |      | 23         |            | ns    |
| t <sub>D(off)</sub>         | Turn-Off DelayTime                                 |  |      | 35         |            | ns    |
| t <sub>f</sub>              | Turn-Off Fall Time                                 |  |      | 26         |            | ns    |
| t <sub>rr</sub>             | Body Diode Reverse Recovery Time                   | I <sub>F</sub> =-20A, dI/dt=500A/μs  |      | 15         |            | ns    |
| Q <sub>rr</sub>             | Body Diode Reverse Recovery Charge                 | I <sub>F</sub> =-20A, dI/dt=500A/μs  |      | 30         |            | nC    |

A. The value of R<sub>θJA</sub> is measured with the device mounted on 1in<sup>2</sup> FR-4 board with 2oz. Copper, in a still air environment with T<sub>A</sub>=25° C. The Power dissipation P<sub>DSM</sub> is based on R<sub>θJA</sub> and the maximum allowed junction temperature of 150° C. The value in any given application depends on the user's specific board design, and the maximum temperature of 175° C may be used if the PCB allows it.

B. The power dissipation P<sub>D</sub> is based on T<sub>J(MAX)</sub>=175° C, using junction-to-case thermal resistance, and is more useful in setting the upper dissipation limit for cases where additional heatsinking is used.

C. Repetitive rating, pulse width limited by junction temperature T<sub>J(MAX)</sub>=175° C. Ratings are based on low frequency and duty cycles to keep initial T<sub>J</sub>=25° C.

D. The R<sub>θJA</sub> is the sum of the thermal impedance from junction to case R<sub>θJC</sub> and case to ambient.

E. The static characteristics in Figures 1 to 6 are obtained using <300μs pulses, duty cycle 0.5% max.

F. These curves are based on the junction-to-case thermal impedance which is measured with the device mounted to a large heatsink, assuming a maximum junction temperature of T<sub>J(MAX)</sub>=175° C. The SOA curve provides a single pulse rating.

G. The maximum current rating is package limited.

H. These tests are performed with the device mounted on 1 in<sup>2</sup> FR-4 board with 2oz. Copper, in a still air environment with T<sub>A</sub>=25° C.

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**TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS**

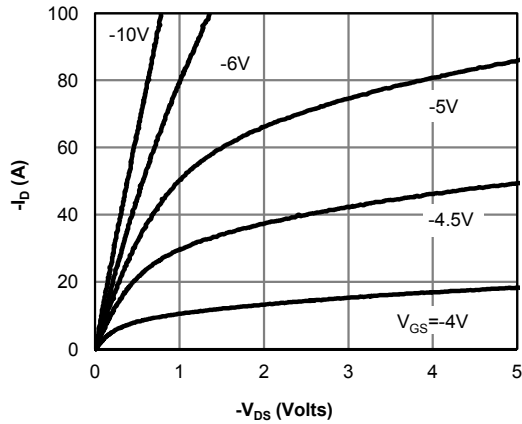


Fig 1: On-Region Characteristics (Note E)

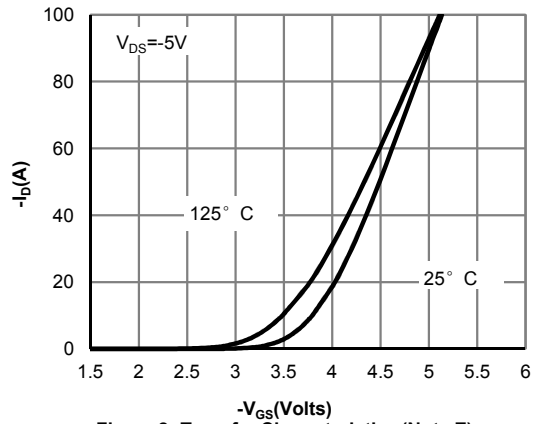


Figure 2: Transfer Characteristics (Note E)

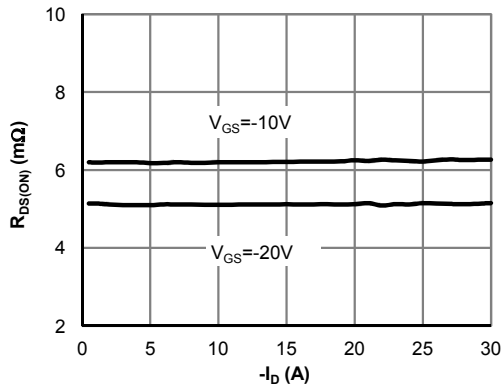


Figure 3: On-Resistance vs. Drain Current and Gate Voltage (Note E)

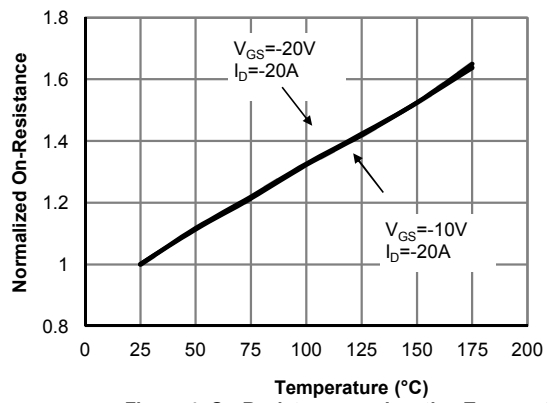


Figure 4: On-Resistance vs. Junction Temperature (Note E)

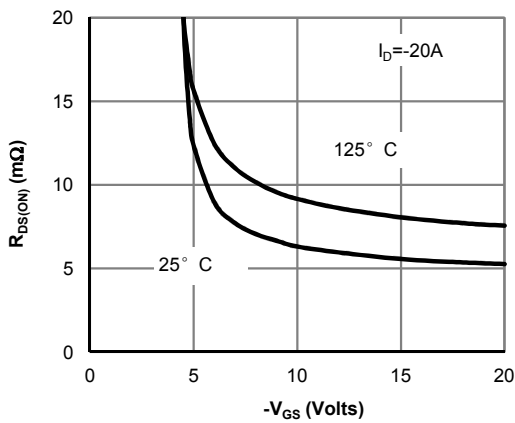


Figure 5: On-Resistance vs. Gate-Source Voltage (Note E)

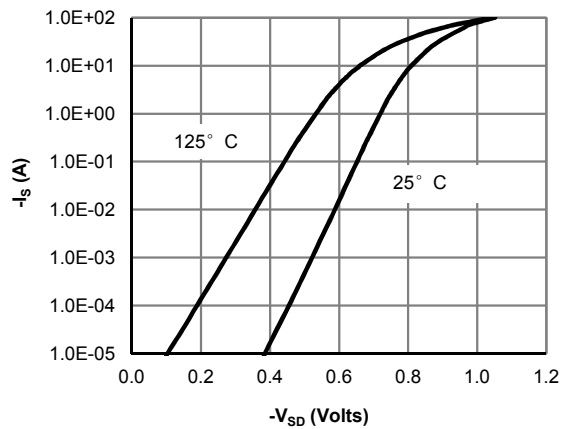


Figure 6: Body-Diode Characteristics (Note E)

**TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS**

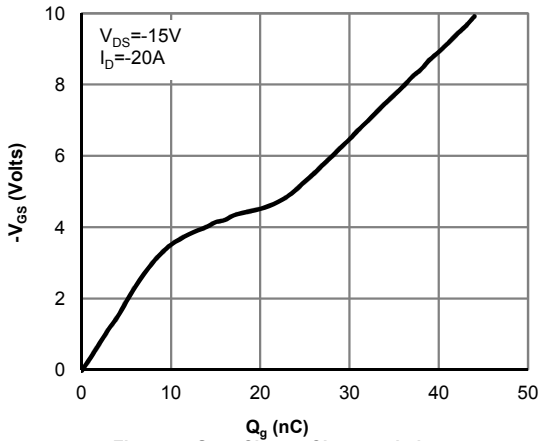


Figure 7: Gate-Charge Characteristics

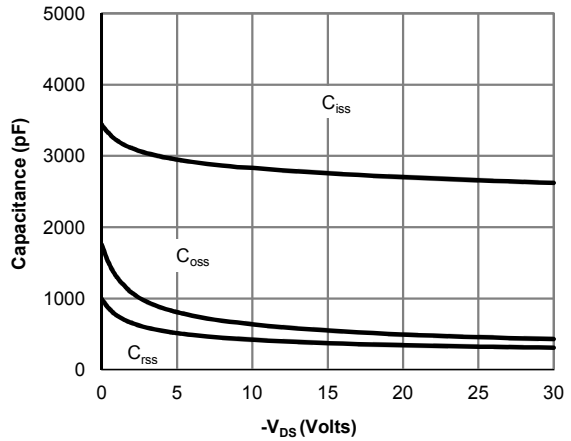


Figure 8: Capacitance Characteristics

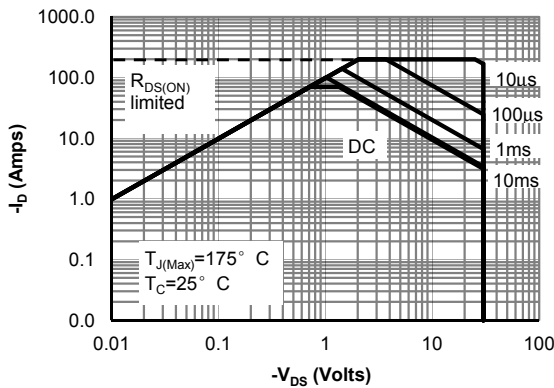


Figure 9: Maximum Forward Biased Safe Operating Area (Note F)

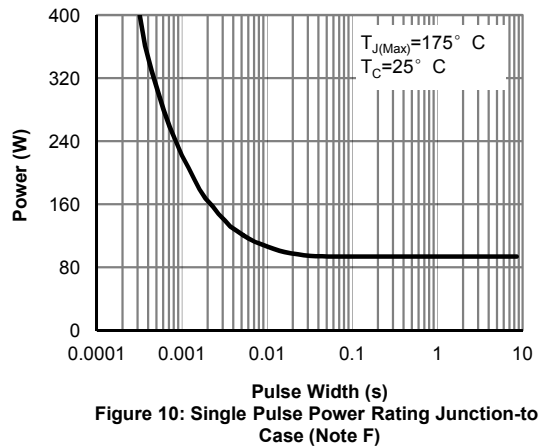


Figure 10: Single Pulse Power Rating Junction-to-Case (Note F)

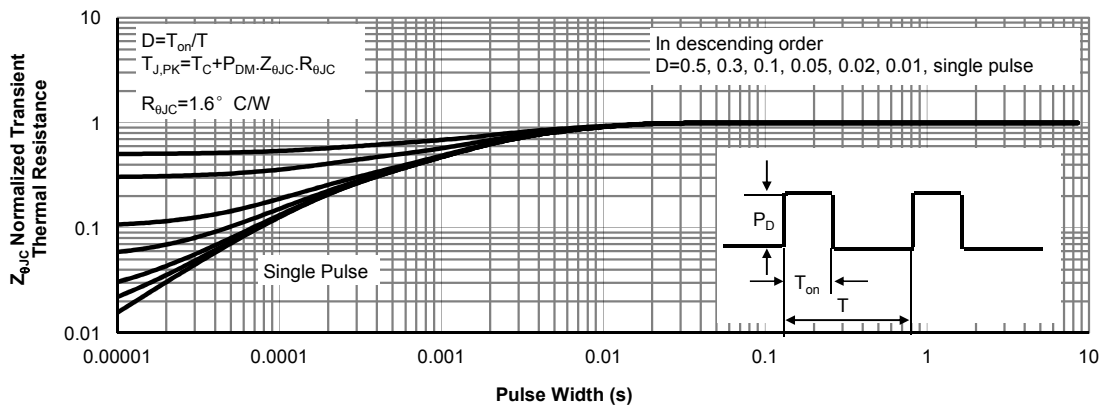


Figure 11: Normalized Maximum Transient Thermal Impedance (Note F)

**TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS**

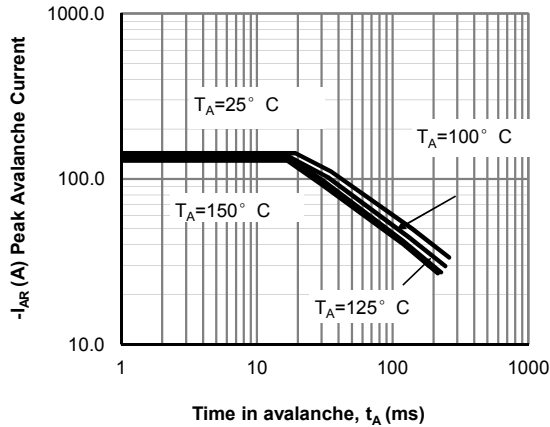


Figure 12: Single Pulse Avalanche capability (Note C)

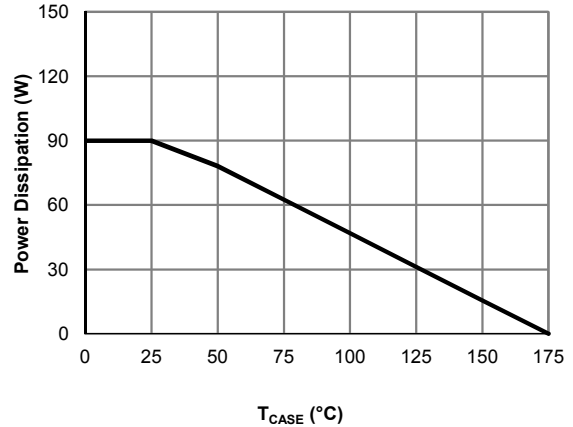


Figure 13: Power De-rating (Note F)

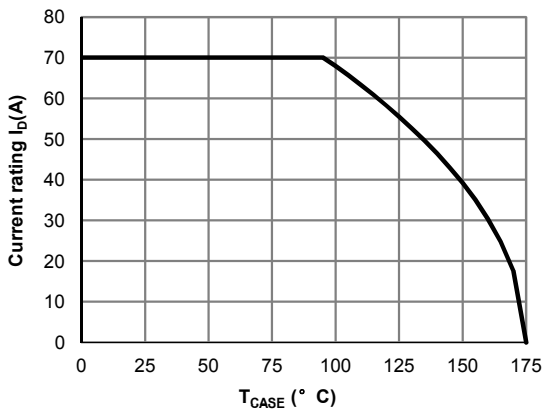


Figure 14: Current De-rating (Note F)

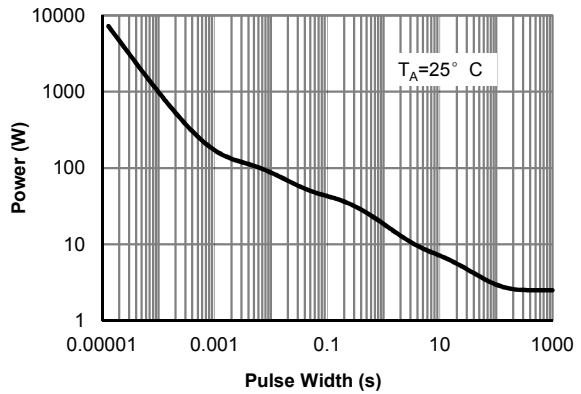


Figure 15: Single Pulse Power Rating Junction-to-Ambient (Note H)

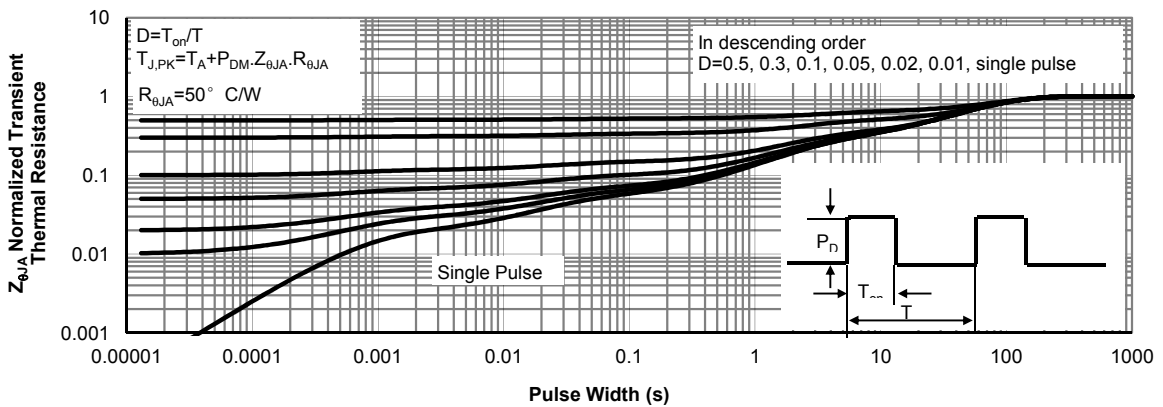
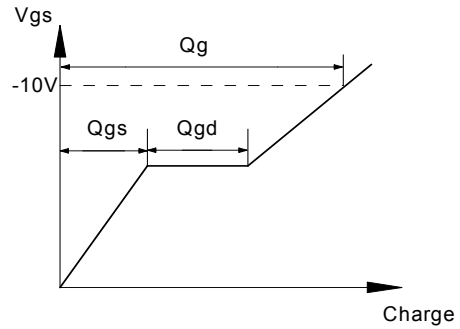
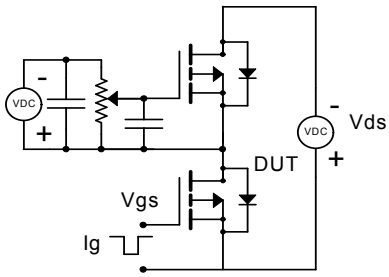
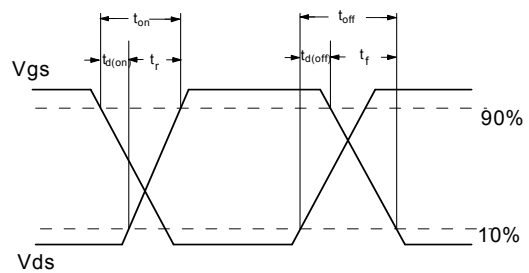
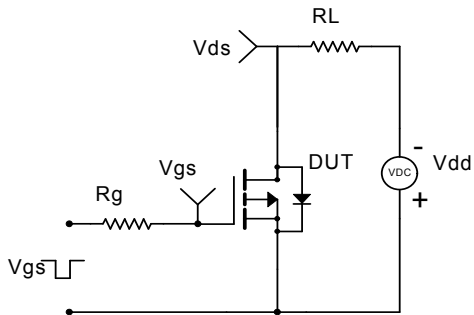


Figure 16: Normalized Maximum Transient Thermal Impedance (Note H)

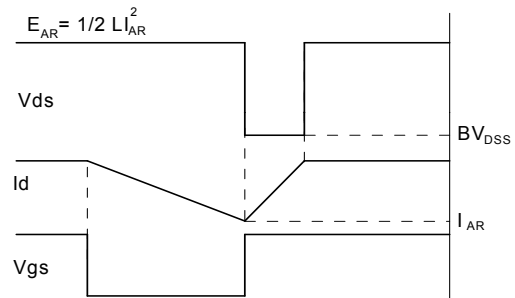
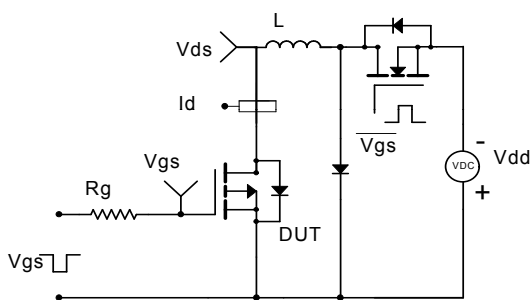
Gate Charge Test Circuit & Waveform



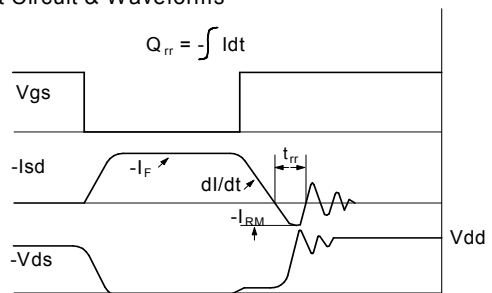
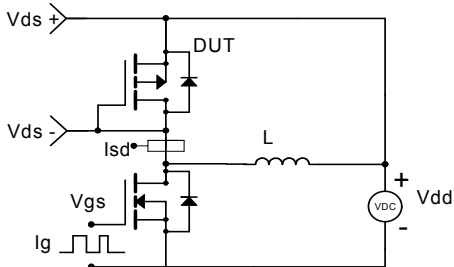
Resistive Switching Test Circuit & Waveforms



Unclamped Inductive Switching (UIS) Test Circuit & Waveforms



Diode Recovery Test Circuit & Waveforms



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